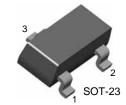
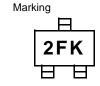


## MMBT2907AK

## **PNP Epitaxial Silicon Transistor**

### **General Purpose Transistor**





1. Base 2. Emitter 3. Collector

## Absolute Maximum Ratings $T_a = 25$ °C unless otherwise noted

Symbol	Parameter	Value	Units	
$V_{CBO}$	Collector-Base Voltage -60 V		V	
V <sub>CEO</sub>	Collector-Emitter Voltage -60 V		V	
V <sub>EBO</sub>	Emitter-Base Voltage	-5	V	
I <sub>C</sub>	Collector Current -600 mA		mA	
P <sub>C</sub>	Collector Power Dissipation	350	mW	
T <sub>J,</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 ~ 150	°C	

## Electrical Characteristics T<sub>a</sub>=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_C = -10\mu A, I_E = 0$	-60		V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage *	$I_C = -10 \text{mA}, I_B = 0$	-60		V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = -10 \mu A, I_C = 0$	-5		V
I <sub>CBO</sub>	Collector Cut-off Current	V <sub>CB</sub> = -50V, I <sub>E</sub> = 0		-0.01	μΑ
h <sub>FE</sub>	DC Current Gain	$V_{CE} = -10V, I_{C} = -0.1 \text{mA}$ $V_{CE} = -10V, I_{C} = -1.0 \text{mA}$ $V_{CE} = -10V, I_{C} = -10 \text{mA}$ $V_{CE} = -10V, I_{C} = -150 \text{mA}$ $V_{CE} = -10V, I_{C} = -500 \text{mA}$	75 100 100 100 50	300	
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage *	$I_C = -150 \text{mA}, I_B = -15 \text{mA}$ $I_C = -500 \text{mA}, I_B = -50 \text{mA}$		-0.4 -1.6	V V
V <sub>BE</sub> (sat)	Base-Emitter Saturation Voltage *	$I_C = -150 \text{mA}, I_B = -15 \text{mA}$ $I_C = -500 \text{mA}, I_B = -50 \text{mA}$		-1.3 -2.6	V V
f <sub>T</sub>	Current Gain Bandwidth Product	$I_C = -50 \text{mA}, V_{CE} = -20 \text{V}, f = 100 \text{MHz}$	200		MHz
C <sub>ob</sub>	Output Capacitance	V <sub>CB</sub> = -10V, I <sub>E</sub> = 0, f = 1.0MHz		8	pF
t <sub>ON</sub>	Turn On Time	$V_{CC} = -30V, I_C = -150mA$ $I_{B1} = -15mA$		50	ns
t <sub>OFF</sub>	Turn Off Time	$V_{CC} = -6V, I_C = -150mA$ $I_{B1} = I_{B2} = -15mA$		110	ns

<sup>\*</sup> Pulse Test: Pulse Width $\leq$ 300 $\mu$ s, Duty Cycle $\leq$ 2%

## **Typical Performance Characteristics**

Figure 1. DC current Gain

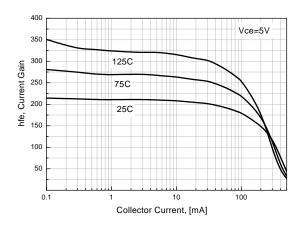


Figure 2. Collector-Emitter Saturation Voltage

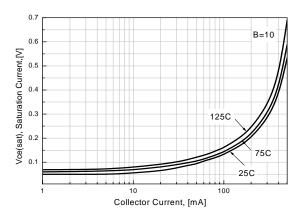


Figure 3. Base-Emitter Saturation Voltage

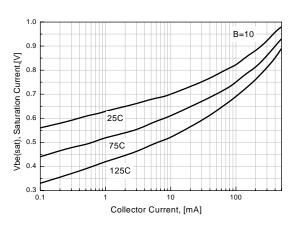


Figure 4. Collector - Base Leakage Current

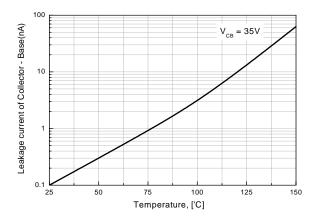


Figure 5. Output Capacitance

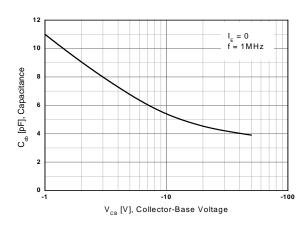
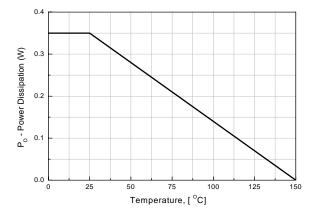
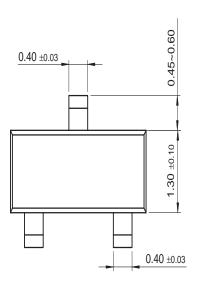


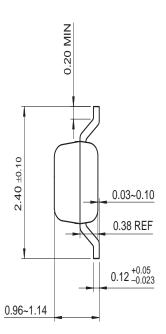
Figure 6. Power Dissipation vs
Ambient Temperature

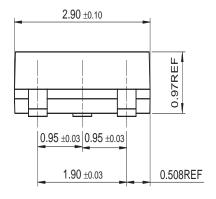


## **Mechanical Dimensions**

# **SOT-23**







Dimensions in Millimeters

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